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Approved by: _____	Reviewed by: _____	Produced by: Tony Su _____		

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1. Scope :

This product specification contains the test results that general performances of A2549 SERIES connector were examined.

2. Part name & part number :

Part name	Part name
Housing	A2549H/HA/HB/HD/HE/HG/HI/HK/HL/HM
Terminal	A2549-T/A2549-T-A/B/C/I/K A2547-T-E
Wafer	A2549WV/WVB/WVI/WVK A2549WR/WRB/WRC/WRI/WRK A2547WVE/WRE

3. Construction、 dimensions、 material & surface finish :

Construction and dimensions shall be in accordance with the referenced drawings.

Material and surface finish shall be as specified below.

Part name		Material	Surface finish
Housing		Nylon66/PBT3%GF	UL 94V-0
Terminal		Phosphor Bronze	Tin-plated
Wafer	Post	Brass	Tin-plated
	Body	Nylon6T/LCP	UL 94V-0

4. Characteristics :

Current rating : 3A AC,DC

Voltage rating : 250V AC,DC

Temperature range : -40°C ~ 105°C

5. Conditions :

The conditions shall be in accordance with the referenced drawing of next page.

Number	Item	Requirement
(1)	Bend up	4° max.
	Bend down	4° max.
	Twisting	3° max.
	Rolling	8° max.
(2)	Bell mouth (flare)	0.2-0.5 mm
(3)	Cut-off tab length	0.2 mm max.
(4)	Extruded wire length	0-1.0 mm
(5)	Seam	Seam shall not be opened and no wire allowed out of crimping area
	Wire strip length	1.2-1.7 mm ref.
(8)	Lance height	0.3 mm ref.

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6. Mechanical test :

6.1 Crimp width, crimp height & crimp strength

Wire Size (AWG)	Terminal Part Number	Conductor(mm)		Insulation(mm)		Crimp Strength (Kg)
		Width	Height	Width	Height	
# 26	A2549-T(-A/B/C)	1.32±0.10	0.72±0.05	1.70±0.10	1.30±0.05	1.80(min)
# 28	A2549-T-C-L	1.25±0.10	0.65±0.05	1.50±0.10	1.15±0.05	1.50(min)

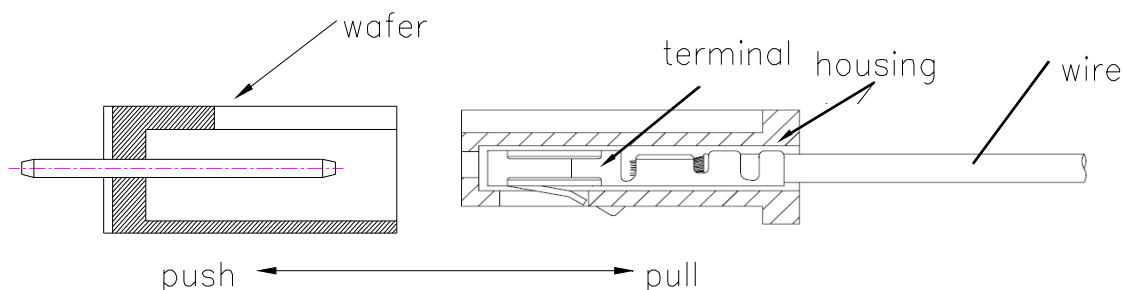
6.2 Insertion force (I.F.) & withdrawal force (W.F.)

(1) Requirement :

Number of Circuits	At initial		At 50th
	I.F. (max)	W.F. (min)	W.F. (min)
2	1.5kg	0.20kg	0.15kg
3	2.0kg	0.40kg	0.32kg
4	3.0kg	0.60kg	0.50kg
5	4.0kg	0.80kg	0.70kg
6	5.0kg	1.00kg	0.90kg
7	5.5kg	1.20kg	1.10kg
8	6.0kg	1.40kg	1.30kg
9	6.5kg	1.60kg	1.50kg
10	7.0kg	1.80kg	1.70kg
11	7.5kg	2.00kg	1.90kg
12	8.0kg	2.20kg	2.10kg
13	8.5kg	2.40kg	2.30kg
14	9.0kg	2.60kg	2.50kg
15	10.0kg	2.80kg	2.70kg
16	10.5kg	3.00kg	2.90kg
17	11.0kg	3.20kg	3.10kg
18	11.5kg	3.40kg	3.30kg
19	12.0kg	3.60kg	3.50kg
20	12.5kg	3.80kg	3.70kg
21	13.0kg	4.00kg	3.90kg
22	13.5kg	4.20kg	4.10kg

(2) Test method : Housing with crimped terminal and wafer shall be mated and unmated on the same axis. Initial insertion and withdrawal forces and withdrawal forces at 50th shall be measured for single circuit and multi-circuits. For the measurement of single circuit , housing lock shall be removed.

Insertion and withdrawal speed : 20±5 mm/minute.



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(3) Test results

Number of Circuits		At initial		AT 50th	N=20
		I.F. (Kg)	W.F. (Kg)	W.F. (Kg)	
2	Max.	1.02	0.95	0.90	
	Min.	0.84	0.84	0.81	
	Ave.	0.94	0.90	0.85	
3	Max.	1.85	1.76	1.66	
	Min.	0.99	0.95	0.91	
	Ave.	1.38	1.31	1.22	
4	Max.	2.68	2.58	2.42	
	Min.	1.14	1.07	1.01	
	Ave.	1.82	1.73	1.59	
5	Max.	3.37	2.84	2.69	
	Min.	1.82	1.39	1.34	
	Ave.	2.63	2.19	2.04	
6	Max.	4.06	3.11	2.97	
	Min.	2.49	1.72	1.68	
	Ave.	3.44	2.66	2.49	
7	Max.	4.76	3.38	3.25	
	Min.	2.99	2.05	2.02	
	Ave.	3.94	3.13	2.94	
8	Max.	5.46	3.65	3.53	
	Min.	3.49	2.38	2.36	
	Ave.	4.44	3.60	3.39	
9	Max.	6.16	3.92	3.81	
	Min.	3.99	2.71	2.70	
	Ave.	4.94	4.07	3.84	
10	Max.	6.86	4.19	4.09	
	Min.	4.49	3.04	3.04	
	Ave.	5.44	4.54	4.29	
11	Max.	7.56	4.46	4.37	
	Min.	4.99	3.37	3.38	
	Ave.	5.94	5.01	4.74	
12	Max.	8.26	4.73	4.57	
	Min.	5.49	3.70	3.68	
	Ave.	6.44	5.48	4.87	
13	Max.	8.96	5.00	4.77	
	Min.	5.99	4.03	3.98	
	Ave.	6.94	5.95	5.27	
14	Max.	9.56	5.27	4.97	
	Min.	6.49	4.36	4.28	
	Ave.	7.44	5.95	5.67	
15	Max.	10.26	5.54	5.17	
	Min.	6.99	4.69	4.58	
	Ave.	7.94	6.42	6.07	
16	Max.	10.96	5.81	5.37	
	Min.	7.49	5.02	4.88	
	Ave.	8.44	6.89	6.47	
17	Max.	11.66	6.08	5.52	
	Min.	7.99	5.35	5.08	
	Ave.	8.94	7.36	6.77	
18	Max.	12.36	6.35	5.67	
	Min.	8.49	5.68	5.28	
	Ave.	9.44	7.83	7.07	
19	Max.	13.06	6.62	5.82	
	Min.	8.99	6.01	5.48	
	Ave.	9.94	8.30	7.37	
20	Max.	13.76	6.89	5.97	
	Min.	9.49	6.34	5.68	
	Ave.	10.44	8.77	7.67	
21	Max.	14.46	7.16	6.12	
	Min.	9.99	6.67	5.88	
	Ave.	10.94	9.24	7.97	
22	Max.	15.16	7.43	6.27	
	Min.	10.49	7.00	6.08	
	Ave.	11.44	9.71	8.27	

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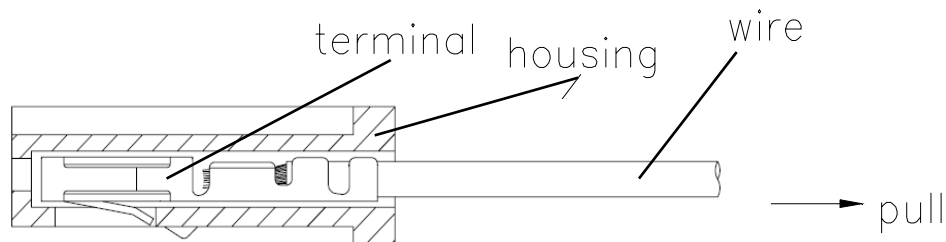
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6.3 Contact retention force

(1) Requirement : 1.20 Kg (min.)

(2) Test method : Crimped terminal shall be mounted in a housing and pulled in an alignment. The load to pull the terminal out of the housing shall be measured.



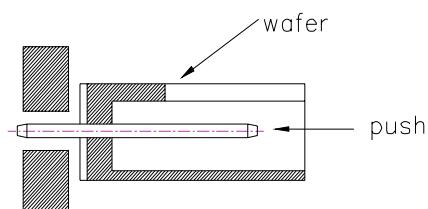
(3) Test results :

Max.	Min.	Ave.	N=10
2.73kg	1.99kg	2.49kg	

6.4 Post retention force

(1) Requirement : 1.20Kg (min.)

(2) Test method : The end of a post shall be pushed in a perpendicular to wafer. The load to make the post start moving shall be measured.



(3) Test results :

Max.	Min.	Ave.	N=10
3.21kg	2.25kg	2.87kg	

7. Electrical test :

7.1 Contact resistance

(1) Requirement : Initial : 20 mΩ (max.)

After environmental test : 30 m Ω (max.)

(2) Condition : Test current : 10 mA (DC)

Open voltage : 20mV (max.)

(3) Test result : See items 8.1 ~ 8.4

7.2 Insulation resistance

(1) Requirement : Initial : 1000 MΩ (min.)

After humidity test : 500 MΩ (min.)

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After thermal shock test : 500 MΩ (min.)

(2) Test method : DC 1000V shall be applied between outer surface of housing and terminal and between adjacent terminals to measure insulation resistance.

(MIL-STD-202 , test method 302 , condition B)

(3) Test result : See items 8.1 & 8.3

7.3 Dielectric withstanding voltage

(1) Requirement : There shall be no breakdown nor flashover.

(2) Test method : Initially AC 1000V (rms) and after humidity and thermal shock tests AC 800V (rms) shall be applied between outer surface of housing and terminal and between adjacent terminals for one minutes. (MIL-STD-202 , test method 301)

Test current : 1mA

(3) Test result : See items 8.1 & 8.3

8. Environment test :

8.1 Humidity

(1) Requirement : Contact resistance shall be 30 milliohms (max.) after the test. Insulation resistance shall be 500 megohms (min.) after the test. There shall be no breakdown nor flashover on dielectric withstanding voltage test.

(2) Test method : Mated connector shall be placed in a humidity chamber of the following conditions. After the test , contact resistance , insulation resistance and dielectric withstanding voltage shall be measured. (MIL-STD-202 , test method 103 , condition A)

Temperature : 40 ±2 °C

Humidity : 90% ~ 95% (RH)

Period : 240 hours continuously

(3) Test results :

Test item	Initial (mΩ)			After test (mΩ)		
Contact resistance	Max.	Min.	Ave.	Max	Min	Ave
	4.32	2.98	3.39	4.28	2.87	3.11

N=30

Test item	Housing-Terminal (MΩ)		Terminal-Terminal (MΩ)	
D.W.V.	Initial	After test	Initial	After test
	Good	Good	Good	Good

N=20

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(2) Test method : Mated connector shall be placed in a humidity chamber of the following conditions. After the test , contact resistance , insulation resistance and dielectric withstanding voltage shall be measured. (MIL-STD-202 , test method 103 , condition A)

Temperature : 40 ± 2 °C

Humidity : 90% ~ 95% (RH)

Period : 240 hours continuously

(3) Test results :

Test item	Initial (mΩ)			After test (mΩ)		
Contact resistance	Max.	Min.	Ave.	Max	Min	Ave
	3.89	2.17	2.54	4.02	2.28	3.68

N=30

Test item	Housing-Terminal (MΩ)		Terminal-Terminal (MΩ)	
D.W.V.	Initial	After test	Initial	After test
	Good	Good	Good	Good

N=20

(D.W.V. : Dielectric withstanding voltage)

8.2 Salt spray

(1) Requirement : Contact resistance shall be 30 milliohms (max.) after the test.

(2) Test method : Mated connector shall be subjected to salt spray test of the following conditions. After the test, specimen shall be washed with running water and dried naturally before the measurement of contact resistance.

Temperature : 40 ± 2 °C

Humidity : 90% ~ 95% (RH)

Period :4(Terminal) 8 or 16 or 24 or 32 or 48 hours

(3) Test result :

Test item	Initial (mΩ)			After test (mΩ)		
Contact resistance	Max.	Min.	Ave.	Max.	Min	Ave.
	3.98	2.17	3.37	4.15	2.28	3.59

N=30

8.3 Thermal shock

(1) Requirement : Contact resistance shall be 30 milliohms (max.) after the test. Insulation resistance shall be 500 megohms (min.) after the test. There shall be no breakdown nor flashover on dielectric withstanding voltage test.

(2) Test method : Mated connector shall be subjected to thermal shock test of the following conditions. After the test , contact resistance , insulation resistance and dielectric withstanding voltage shall be measured.

1 cycle consists of :

-55 °C for 30 minutes

+85 °C for 30 minutes

Times of cycles : 25 cycles

(3) Test results :

Test item	Initial (mΩ)			After test (mΩ)		
Contact resistance	Max.	Min.	Ave.	Max.	Min	Ave.
	4.25	2.17	3.47	3.86	2.17	3.54

N=30

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Test item	Housing-Terminal (MΩ)		Terminal-Terminal (MΩ)		N=20
Insulation resistance	Initial	After test	Initial	After test	
	1000min	1000min	1000min	1000min	

Test item	Housing-Terminal (MΩ)		Terminal-Terminal (MΩ)		N=20
D.W.V.	Initial	After test	Initial	After test	
	Good	Good	Good	Good	

D.W.V. : Dielectric withstanding voltage

8.4 Vibration

(1) Requirements : Contact resistance shall be 30 milliohms (max.) after the test. There shall be no current discontinuity longer than 1 microsecond during the test.

(2) Test method : Mated connector shall be mounted on a PCB and subjected to a vibration test of the following conditions. During the test , current continuity shall be checked. After the test , contact resistance shall be measured.

(MIL-STD-202 , test method 201)

Frequency : 10~55~10 Hz/min.

Amplitude : 1.5 mm

Direction : 1. Axis of up and down

2. Axis of right and left

3. Axis of front and back

(3) Test result :

Test item	Initial (mΩ)			After test (mΩ)			N=30
Contact resistance	Max.	Min.	Ave.	Max.	Min.	Ave.	
	4.36	2.22	3.41	3.97	2.18	3.17	

Current discontinuity : There shall be no current discontinuity longer than 1 microsecond during the test.

8.5 Solderability

(1) Requirements : Solder-dipping section shall be covered by solder entirely.

(2) Test method : Fluxed soldering section of shrouded header shall be dipped in solder of the following conditions.

Solder temperature : 235 ±5 °C

Immersion period : 3-5 seconds

(3) Test result : Good.

8.6 Resistance to soldering heat

(1) Requirements : There shall be no deformation nor damage which may affect the performance.

(2) Test method : Specimen shall be mounted on a PCB (inserted only) and subjected to resistance to soldering heat test of the following conditions.

Solder temperature : 250 ±5 °C

Immersion period : 3-5 seconds

(3) Test result : Good.